Applicant(s)/Patent Under Application/Control No. Reexamination 10/785,259 OHKAWA ET AL. Notice of References Cited Examiner **Art Unit** Page 1 of 1 B. Chen 1762 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 02-1990 Koskenmaki, David C. 428/328 Α US-4,904,526 US-2003/0124392 A1 07-2003 Bright, Clark I. 428/698 В С US-5,156,720 A 10-1992 Rosenfeld et al. 205/76 US-D US-Ε US-F US-G US-Н US-US-US-K US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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